FEATURES

- Lower R_{DS(on)}
- ☐ Improved Inductive Ruggedness
- □ Fast Switching Times
- ☐ Lower Input Capacitance
- ☐ Extended Safe Operating Area
- ☐ Improved High Temperature Reliability

$BV_{DSS} = 60 V$

 $R_{DS(on)} = 5.0 \Omega$

 $I_D = 200 \text{ mA}$





1.Gate 2. Source 3. Drain

Product Summary

Part Number	BV _{DSS}	R _{DS} (on)	I _D
2N7002	60V	5.0Ω	115mA

Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
V _{DSS}	Drain-to-Source Voltage	60	V
	Continuous Drain Current (T _C =25°C)	115	mA
Continuous Drain Current (T _C =100°C)		73	
I _{DM}	Drain Current-Pulsed ①	800	mA
V_{GS}	Gate-to-Source Voltage	±20	V
Б	Total Power Dissipation (T _C =25 °C)	0.2	W
P _D	Linear Derating Factor	1.6	mW/℃
	Operating Junction and	FF to 1450	ာိ
T_J , T_STG	Storage Temperature Range	- 55 to +150	

Thermal Resistance

Symbol	Characteristic	Тур.	Max.	Units
R_{\ThetaJA}	Junction-to-Ambient		625	СW



2N7002MTF

Electrical Characteristics (T_C =25 $^{\circ}$ C unless otherwise specified)

Symbol	Characteristic	Min.	Тур.	Max.	Units	Test Condition	
BV _{DSS}	Drain-Source Breakdown Voltage	60	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$	
V _{GS(th)}	Gate Threshold Voltage	1.2	-	2.5	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
	Gate-Source Leakage, Forward	-	-	100	^	V _{GS} = 20V	
I _{GSS}	Gate-Source Leakage, Reverse	-	-	-100	nA	V _{GS} = -20V	
	Ducin to Course Looke as Course	-	-	1.0	μА	V _{GS} = 40V	
I _{DSS}	Drain-to-Source Leakage Current	-	-	500	μΛ	$V_{GS} = 40V, T_{C} = 125^{\circ}C$	
I _{D(ON)}	On-State Drain-Source Current	0.5	-	-	Α	$V_{DS} = 10V, V_{GS} = 10V$	
R _{DS(on)}	Static Drain-Source On-State Resistance ②	-	-	5.0	Ω	V _{GS} = 10V, I _D = 0.5A	
g _{fs}	Forward Transconductance ②	0.08	-	-	S	$V_{DS} = 15V, I_{D} = 0.2A$	
C _{iss}	Input Capacitance	-	-	50			
C _{oss}	Output Capacitance	-	-	25	pF	$V_{DS} = 25V, V_{GS} = 0V,$ f = 1.0MHz	
C _{rss}	Reverse Transfer Capacitance	-	-	5		I = I.UIVIMZ	
t _{d(on)}	Turn-On Delay Time	-	-	20			
t _r	Rise Time	-	-	-		$V_{DD} = 30V, I_{D} = 0.2A$	
t _{d(off)}	Turn-Off Delay Time	-	-	20	ns	$R_G = 25\Omega$ (2)(3)	
t _f	Fall Time	-	-	-			

Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Тур.	Max.	Units	Test Condition
Is	Continuous Source Current	-	1	115	mA	Integral reverse pn-diode
I _{SD}	Pulse Source Current 1	-	-	800	mA	In the MOSFET
V _{SD}	Diode Forward Voltage ②	-	-	1.5	V	$T_A = 25 ^{\circ}\text{C}, I_S = 115\text{mA}$ $V_{GS} = 0\text{V}$

Notes;

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ② Pulse Test : Pulse Width = 250 μ s, Duty Cycle \leq 2%
- ③ Essentially Independent of Operating Temperature



Fig 1. Output Characteristics

Vanity

Vanity

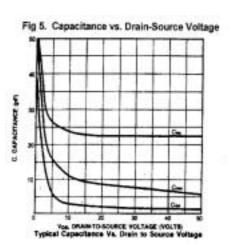
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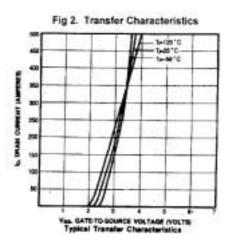
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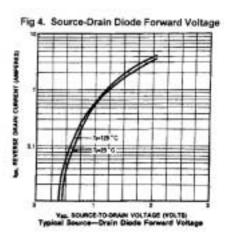
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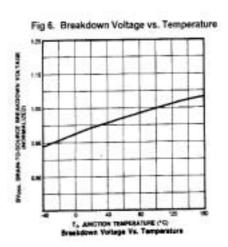
Typical Saturation Characteristics

Fig 3. On-Resistance vs. Drain Current

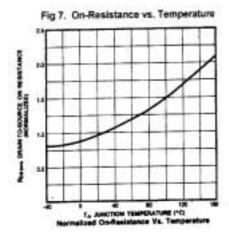














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